Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/747,768	HAN, IL-SEOK	
Examiner	Art Unit	
Christian Wilson	2891	

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Class	Subclass	Date	Examiner
438	460	6/15/2005	00W
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCI (INCLUDING SEA	H NOTES ARCH STRATEG	Y)
	DATE	EXMR
EAST text	6/15/2005	000
EPO, JPO, Derwent		